

Reliability of Transport Properties for Bulk Thermoelectrics

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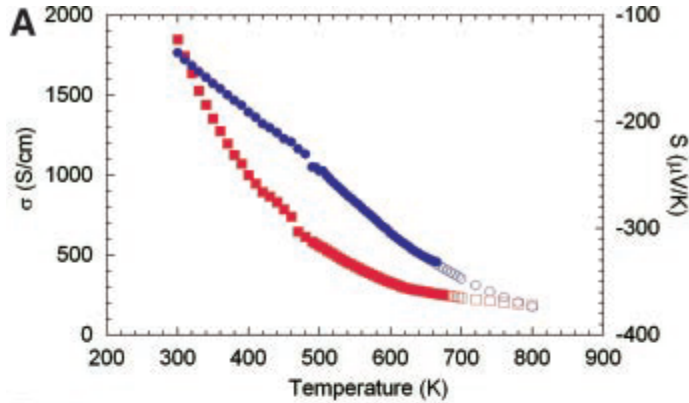


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Implementing Agreement on Advanced Materials for Transportation (AMT)***

Most Cited Thermoelectric Papers

1. Title: [Thin-film thermoelectric devices with high room-temperature figures of merit](#) Author(s): Venkatasubramanian, R; Siivola, E; Colpitts, T; et al. Source: NATURE Volume: 413 Issue: 6856 Pages: 597-602 Published: OCT 11 2001 Times Cited: [1,558](#)
2. Title: [Large thermoelectric power in NaCo₂O₄ single crystals](#) Author(s): Terasaki, I; Sasago, Y; Uchinokura, K, Source: PHYSICAL REVIEW B Volume: 56 Issue: 20 Pages: 12685-12687 Published: NOV 15 1997 Times Cited: [1,217](#)
3. [EFFECT OF QUANTUM-WELL STRUCTURES ON THE THERMOELECTRIC FIGURE OF MERIT](#) Author(s): HICKS, LD; DRESSELHAUS, MS Source: PHYSICAL REVIEW B Volume: 47 Issue: 19 Pages: 12727-12731 Published: MAY 15 1993 Times Cited: [1,017](#)
4. [Quantum dot superlattice thermoelectric materials and devices](#) Author(s): Harman, TC; Taylor, PJ; Walsh, MP; et al. Source: SCIENCE Volume: 297 Issue: 5590 Pages: 2229-2232 Published: SEP 27 2002 Times Cited: [925](#)
5. Title: [Enhanced thermoelectric performance of rough silicon nanowires](#) Author(s): Hochbaum, Allon I.; Chen, Renkun; Delgado, Raul Diaz; et al. Source: NATURE Volume: 451 Issue: 7175 Pages: 163-U5 Published: JAN 10 2008 Times Cited: [909](#)
6. Title: [Cubic AgPbmSbTe_{2+m}: Bulk thermoelectric materials with high figure of merit](#) Author(s): Hsu, KF; Loo, S; Guo, F; et al. Source: SCIENCE Volume: 303 Issue: 5659 Pages: 818-821 Published: FEB 6 2004 Times Cited: [905](#)
7. Title: [Filled skutterudite antimonides: A new class of thermoelectric materials](#) Author(s): Sales, BC; Mandrus, D; Williams, RK Source: SCIENCE Volume: 272 Issue: 5266 Pages: 1325-1328 Published: MAY 31 1996 Times Cited: [833](#)
8. Title: [High-thermoelectric performance of nanostructured bismuth antimony telluride bulk alloys](#) Author(s): Poudel, Bed; Hao, Qing; Ma, Yi; et al. Source: SCIENCE Volume: 320 Issue: 5876 Pages: 634-638 Published: MAY 2 2008 Times Cited: [617](#)
9. Title: [Skutterudites: A phonon-glass-electron crystal approach to advanced thermoelectric energy conversion applications](#) Author(s): Nolas, GS; Morelli, DT; Tritt, TM Source: ANNUAL REVIEW OF MATERIALS SCIENCE Volume: 29 Pages: 89-116 Published: 1999 Times Cited: [287](#)
10. Title: [Properties of single crystalline semiconducting CoSb₃](#) Author(s): Caillat, T; Borshchevsky, A; Fleurial, JP Source: JOURNAL OF APPLIED PHYSICS Volume: 80 Issue: 8 Pages: 4442-4449 Published: OCT 15 1996 Times Cited: [271](#)

Mystery in Reporting Thermal Conductivity

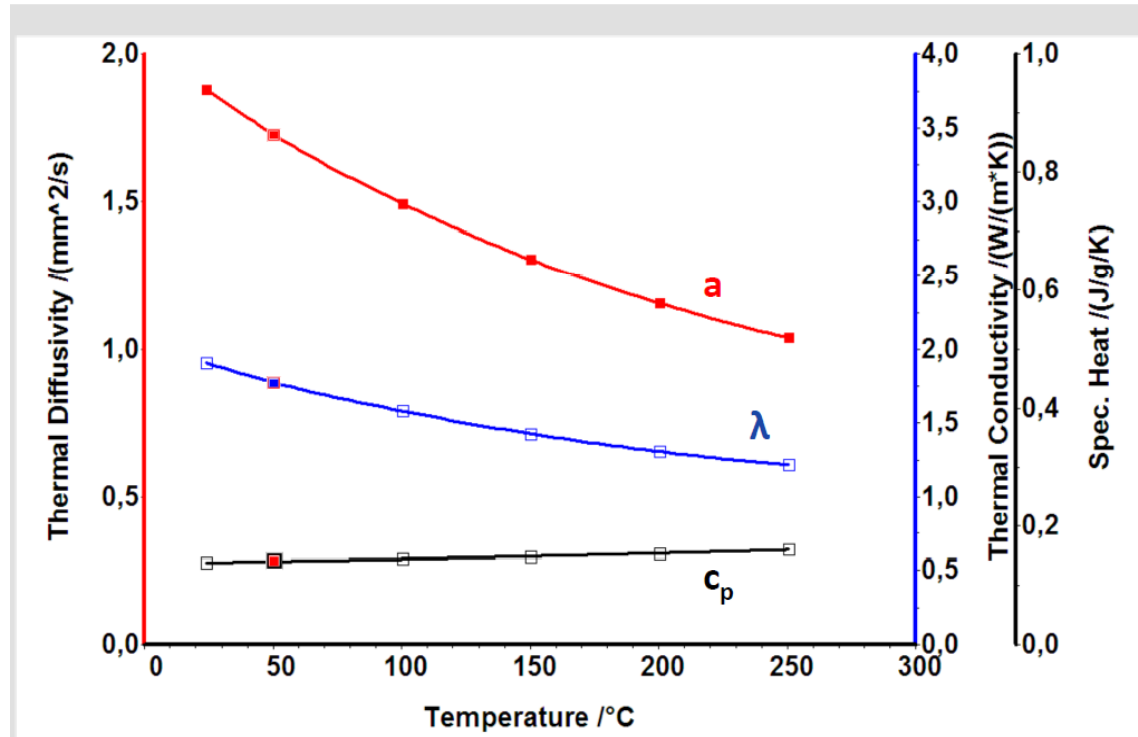
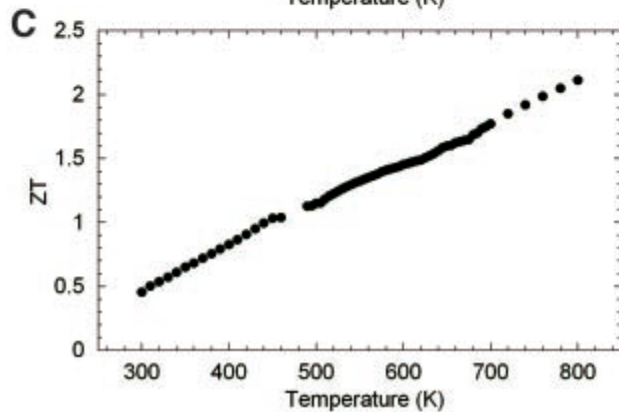
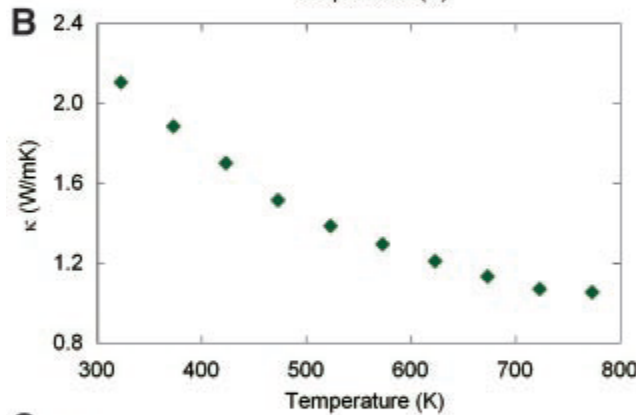


$$ZT = s^2 \sigma T / k$$

$$k = \alpha C_p D$$

Thermal Conductivity of PbTe

NETZSCH



- Thermal conductivity is not measured
- Thermal conductivity is calculated

Annex VIII Participants

- **IEA-AMT Thermoelectric Annex**

- Annex lead: Oak Ridge National Laboratory (H. Wang)
- USA: Clemson (T. Tritt, S. Zhu); Marlow (J. Sharp); Corning (A. Mayolet, J. Senawiratne) and ZT-Plus (F. Harris)
- China: SICCAS (S.Q. Bai, L. Chen)
- Canada: Natural Resource Canada (J. Lo); University of Waterloo (Holger Kleinke); University of Quebec at Chicoutimi (Laszlo Kiss)
- Germany: Fraunhofer IPM (H. Böttner, J. König)



- **IEA-AMT members countries:**

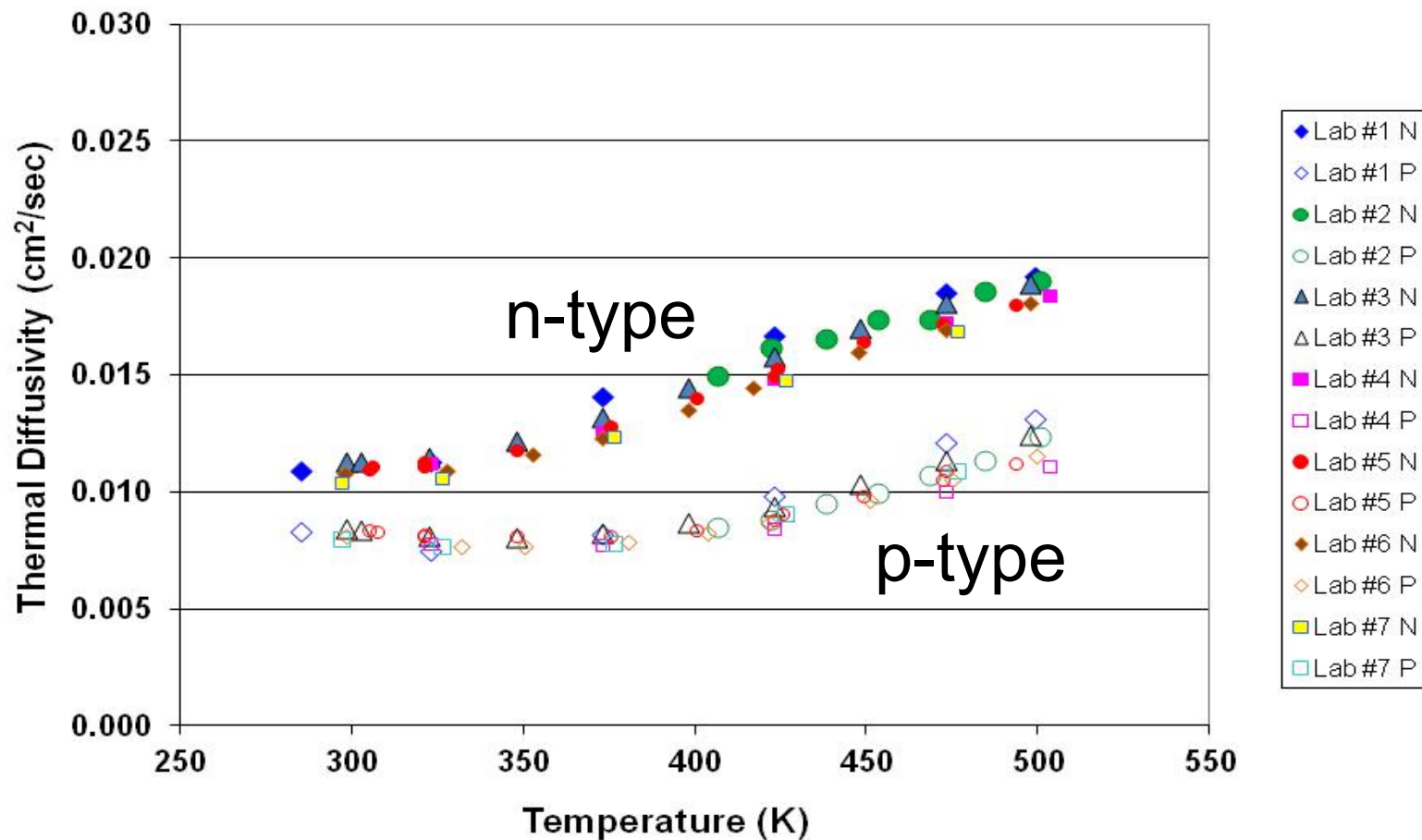
- UK: NPL
- Finland: VTT
- Israel:
- Australia:
- Republic of Korea: KERI (H. W. Lee)



Marlow Materials Selected for Transport Properties Round-Robin Tests

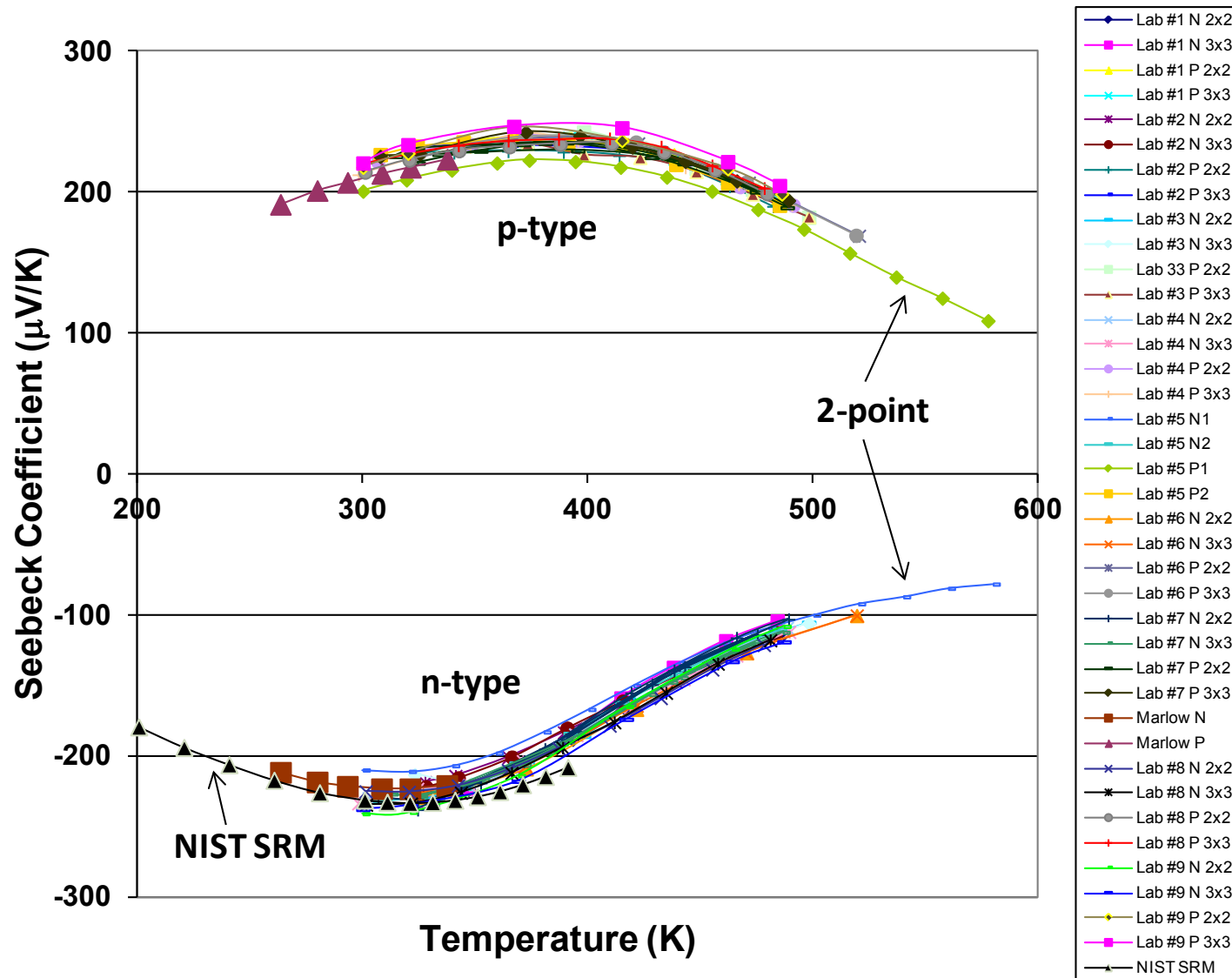
- **Materials: $\text{Bi}_2\text{Te}_{3.005}$ (n-type) $\text{Bi}_{0.5}\text{Sb}_{1.5}\text{Te}_3$ (p-type)**
- **Four-sample Sets**
 - Thermal diffusivity: 12.7 mm diameter disk
 - Specific heat: 4 mm diameter disk
 - Seebeck coefficient and electrical resistivity:
2 x 2 x 15 mm³ bar, 3 x 3 x 12 mm³ bar
- **Temperature range: 300-500K**
- **No ranking of the labs (lab numbers are assigned randomly in each plot)**

Round-robin 1: Thermal Diffusivity

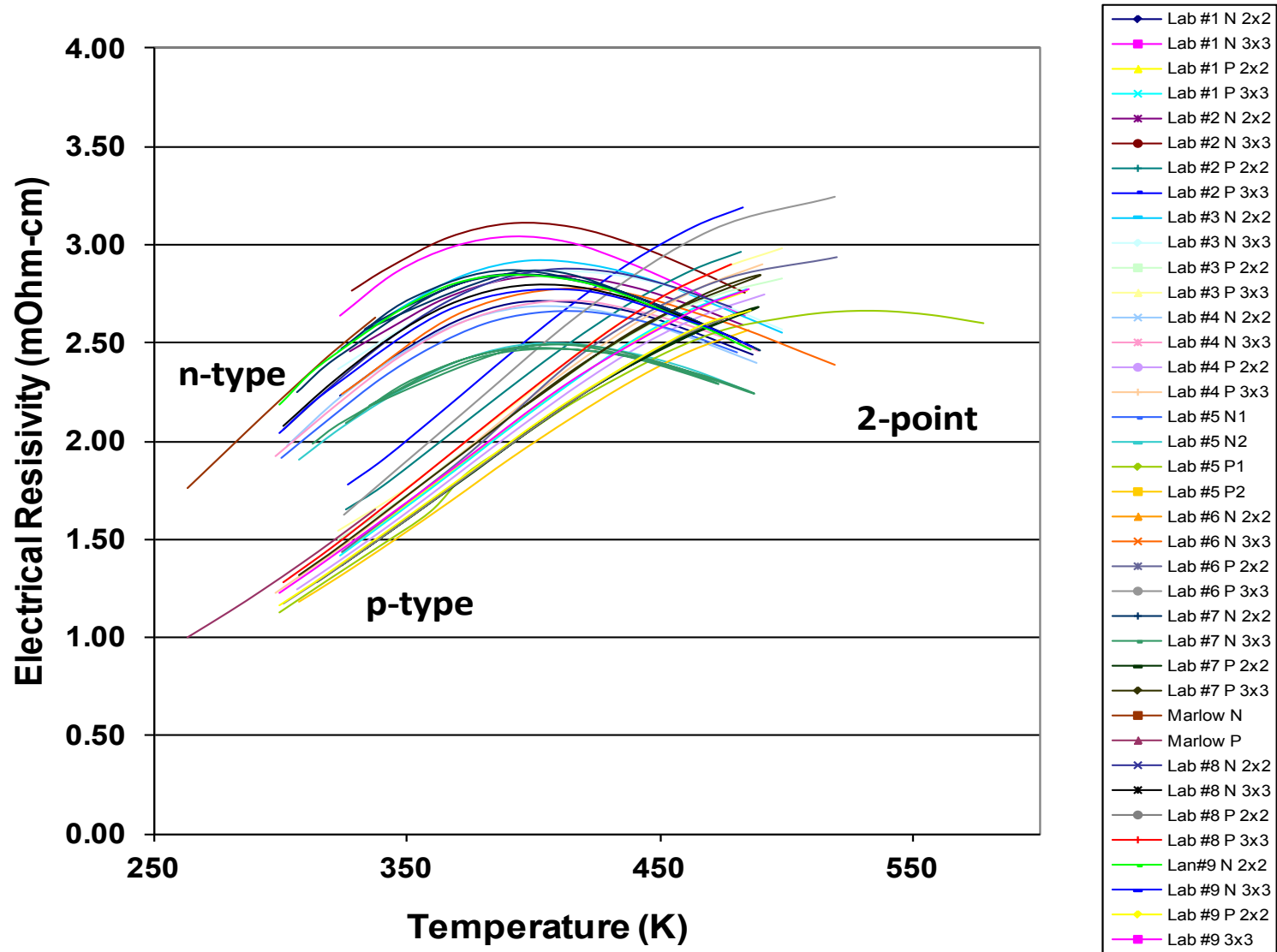


Results from 8 labs

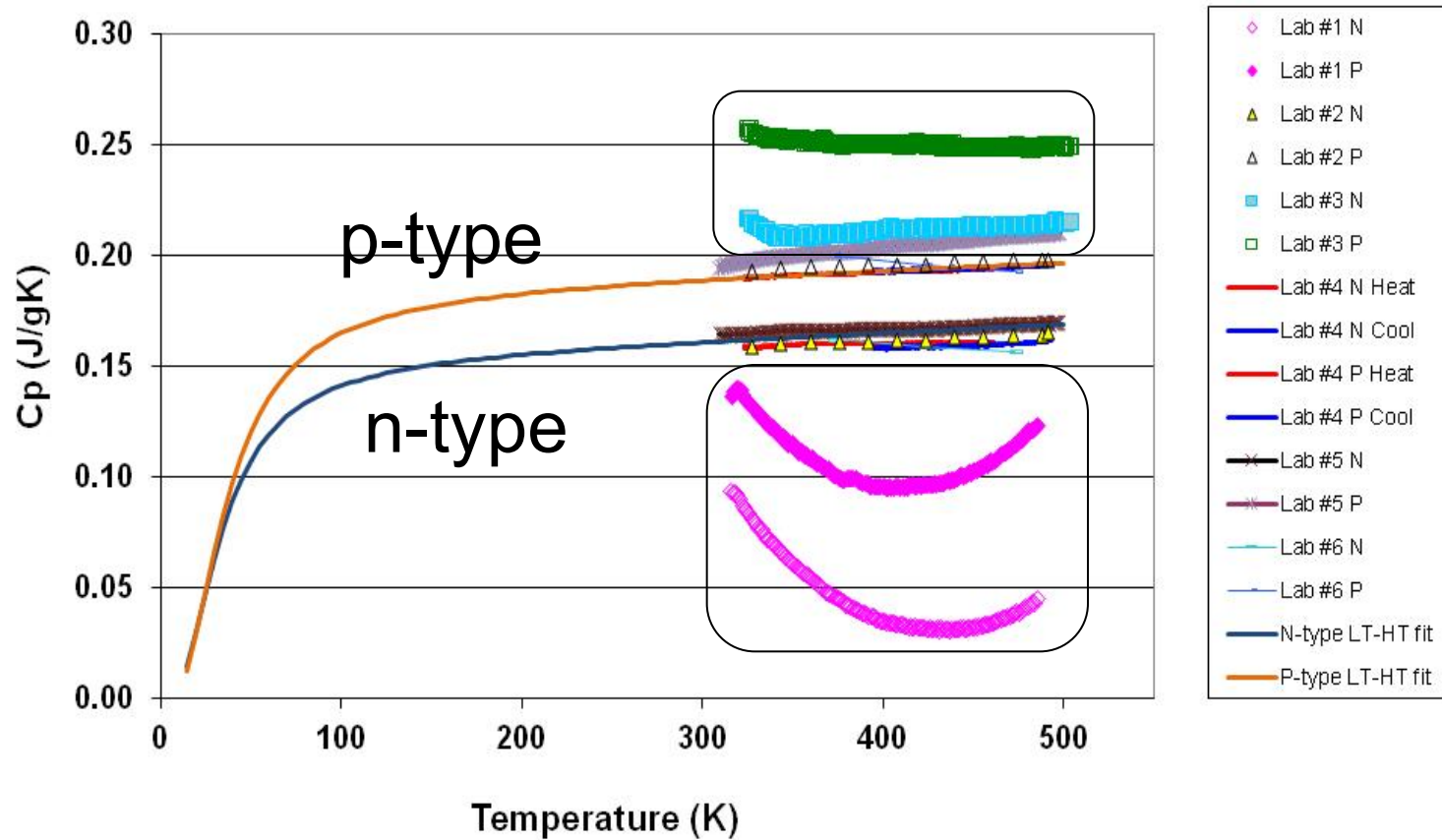
Round-robin 1: Seebeck Coefficient



Round-robin 1: Electrical Resistivity



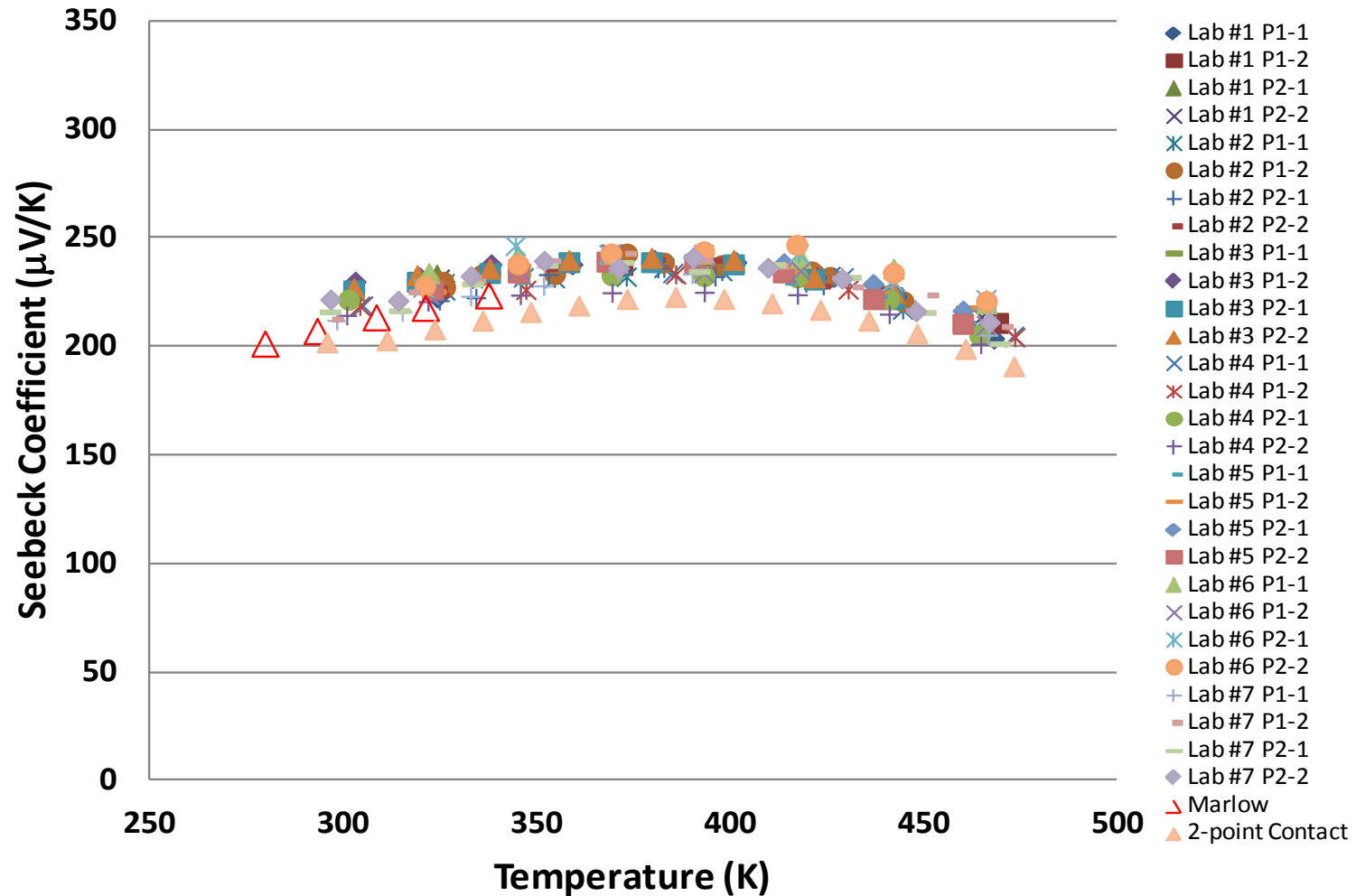
Cp of Round-robin 1 with Debye Fit



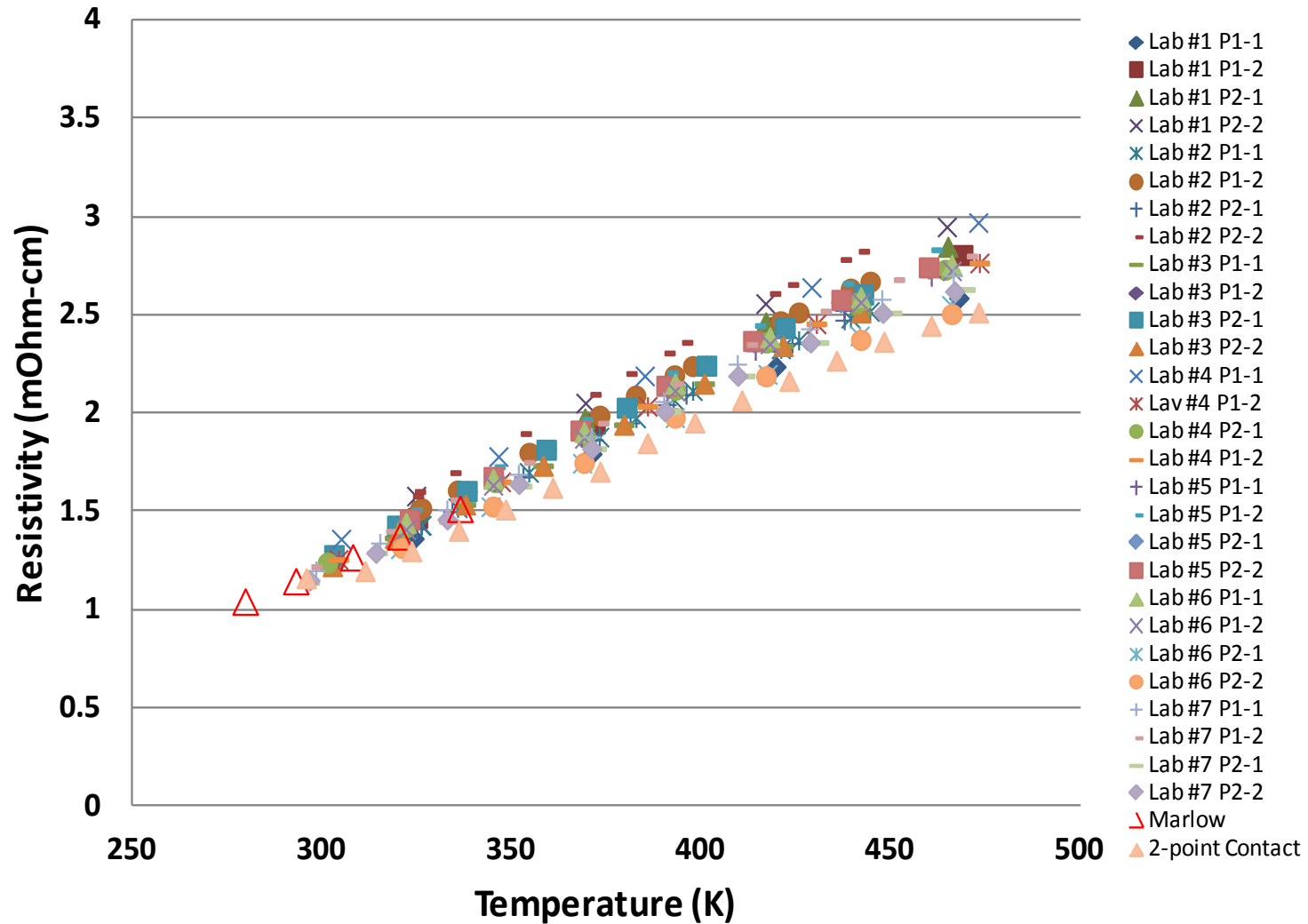
Round-robin #2 Started in October 2010

- Procedures for DSC prepared by ORNL
- Two sets of p-type samples
 - Set #1: ORNL -> Clemson-> Corning -> ZT-Plus -> Germany -> China -> Canada
 - Set #2: China -> (Japan) -> Germany -> ORNL -> Clemson-> Corning -> ZT-Plus -> Canada
- Completed in September 2011
- Report to IEA-AMT: October 2011
- IEA-AMT Topical report November 2011

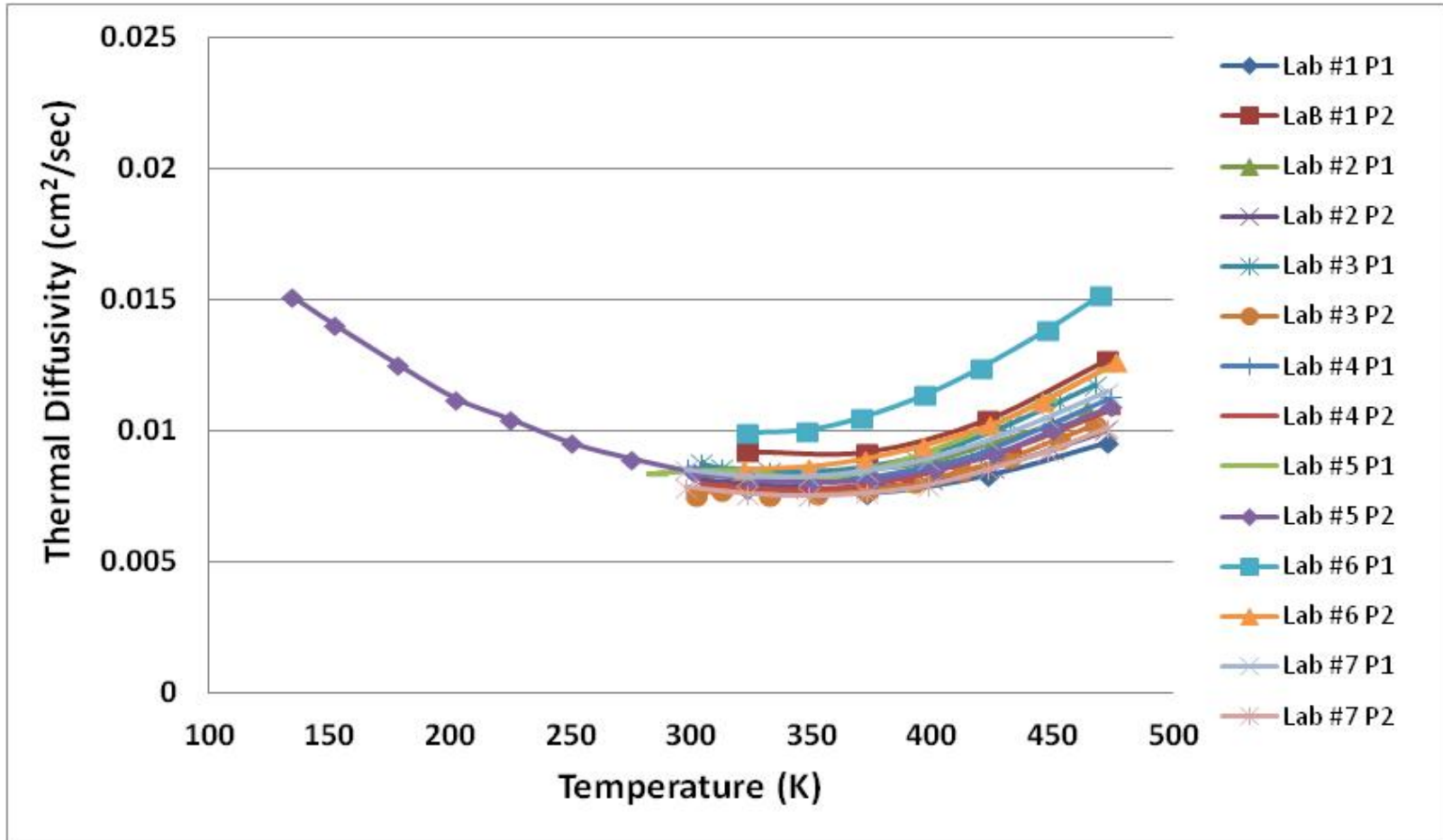
Round-robin 2: Seebeck Coefficient



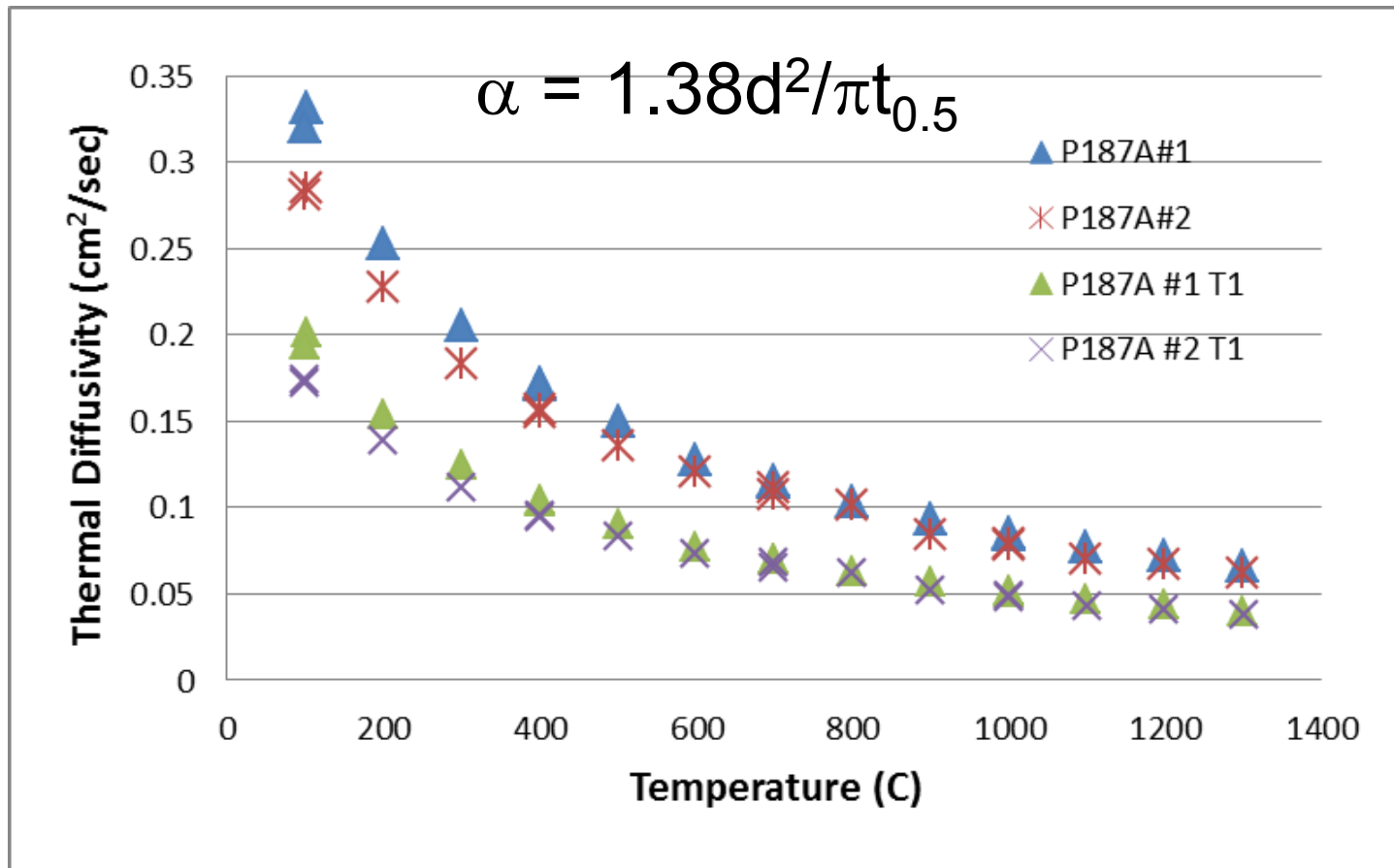
Round-robin 2: Electrical Resistivity



Round-robin 2: Thermal Diffusivity



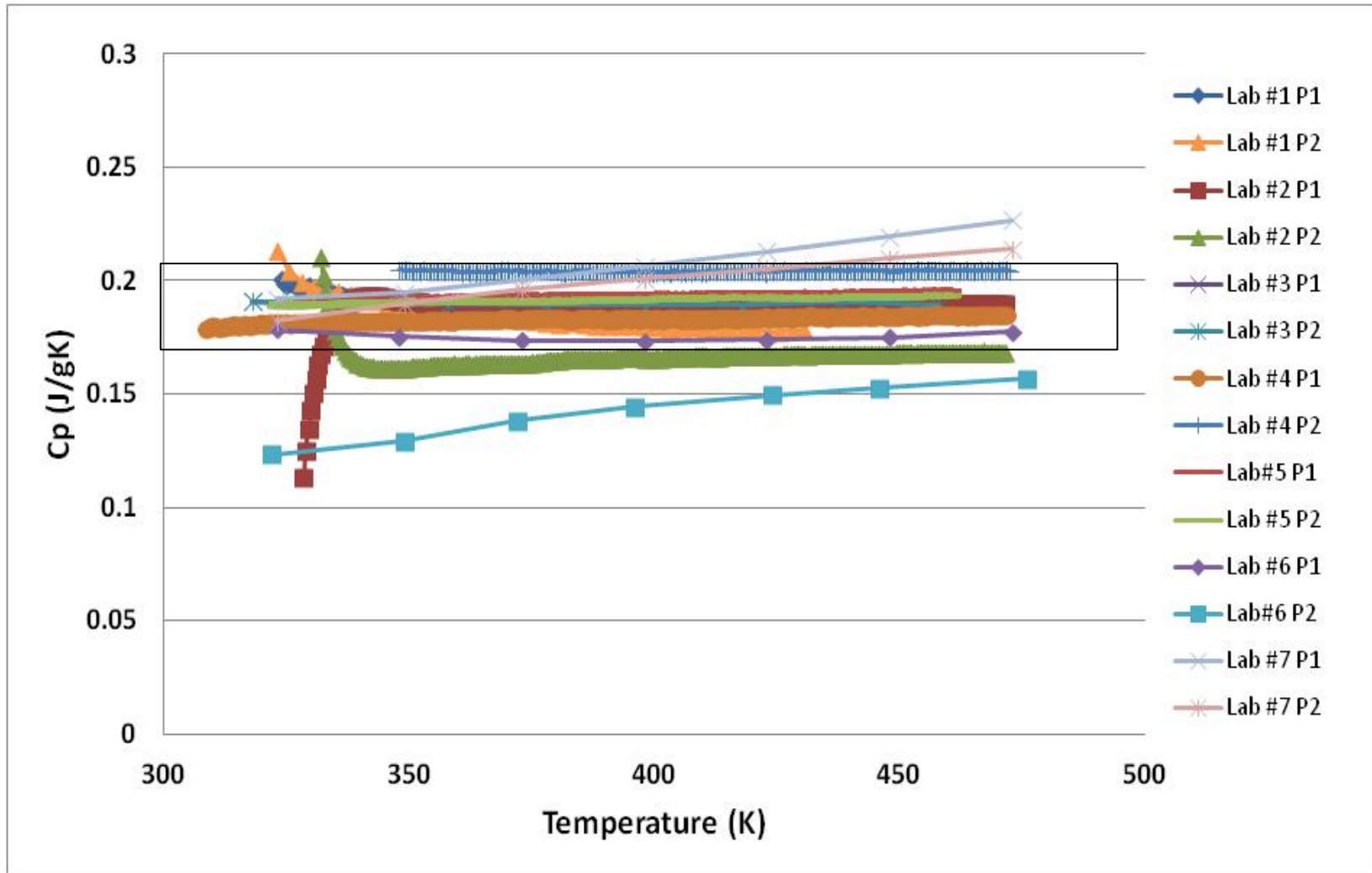
How Difficult is Thickness Measurement?



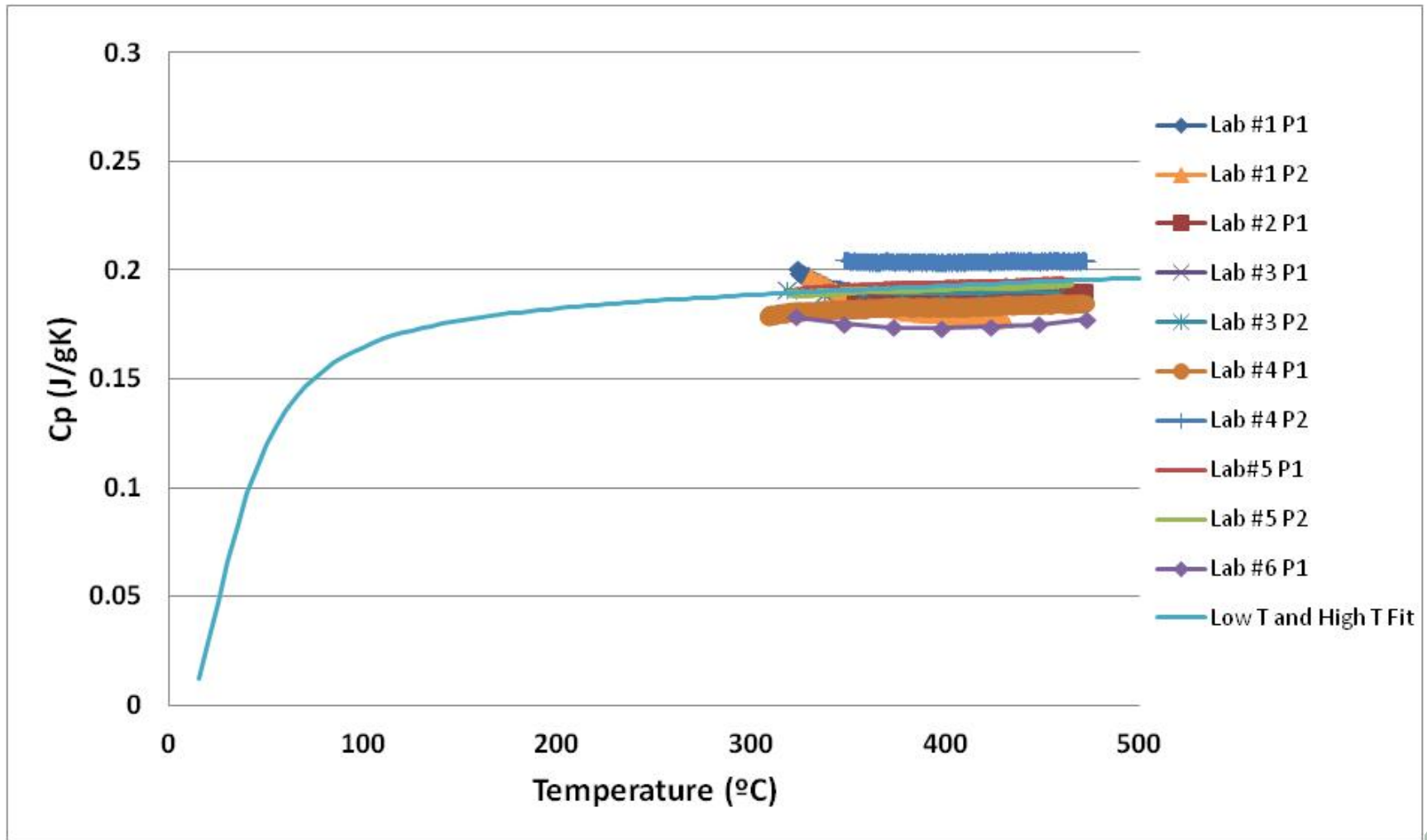
Thickness = 1.568 mm

Thickness = 2.011 mm

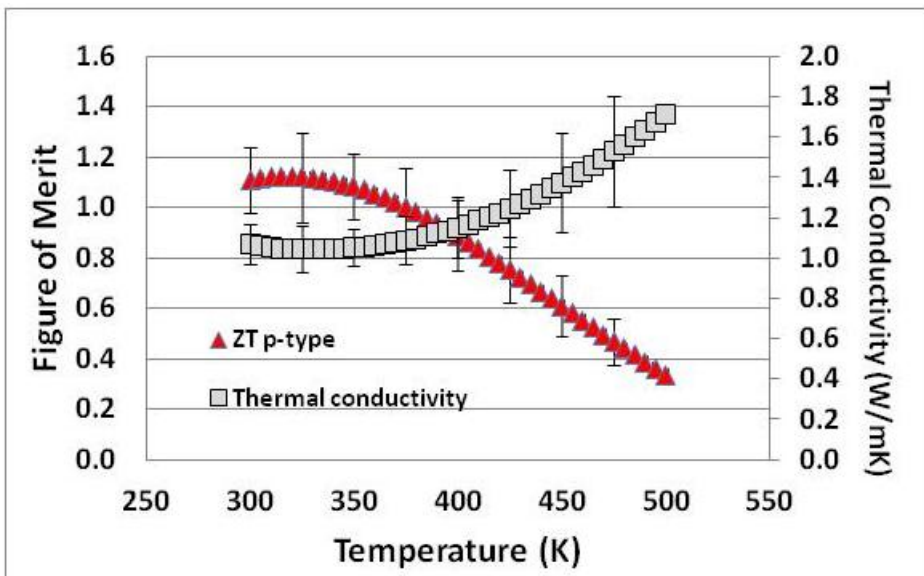
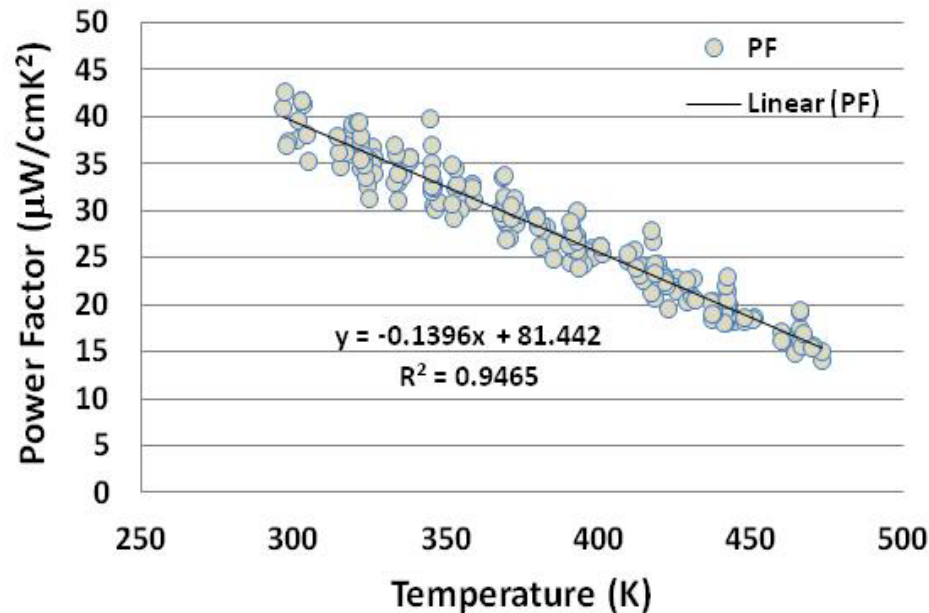
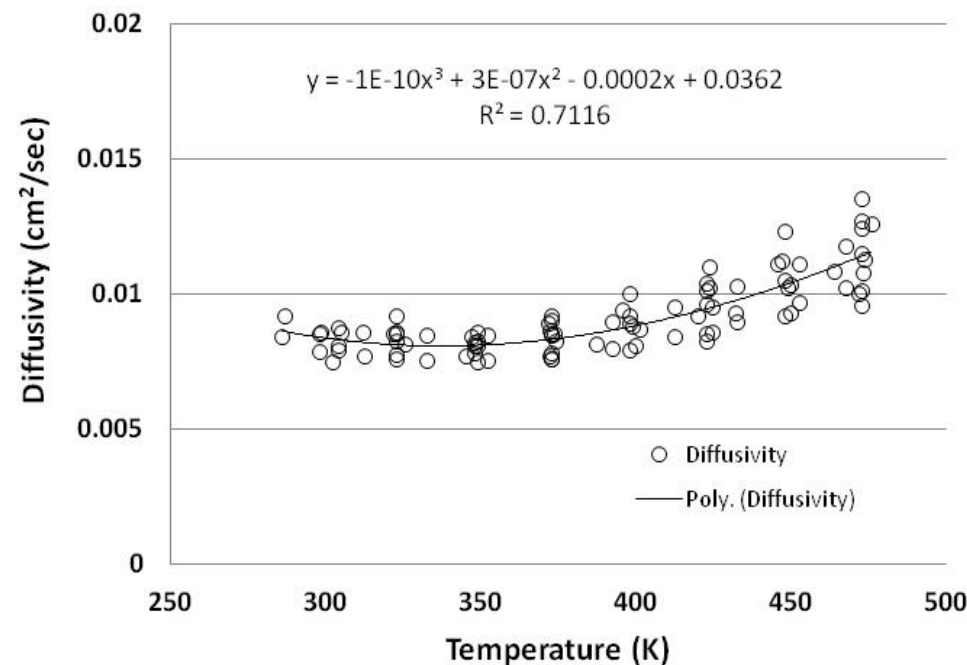
Round-robin 2: Specific Heat



Cp of Round-robin 2 with Debye Fit



Calculation of ZT: P-type



Calculated from Full Scatter

- PF: ± 7.1 to 11.7%
- K: ± 8.5 to 17.9%
- ZT: ± 11.7 to 20.9%

Summary

- **Reliability of transport property is critical for vehicle applications**
- **IEA-AMT is addressing this issue timely**
- **Round-robin #3: 300K-800K**
 - **GMZ half-Heusler materials for the round-robin effort (March 2012)**
 - **Materials processed and machined at GMZ Energy and first set measurements completed in May 2012**